

Docket No.: H6808.0053/P053
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Shuichi Nakagawa et al.

Application No.: Not Yet Assigned

Filed: Concurrently Herewith

Art Unit: N/A

For: TWO AXIS STAGE FOR MICROSCOPE

Examiner: Not Yet Assigned

CLAIM FOR PRIORITY

MS Patent Application
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Applicant hereby claims priority under 35 U.S.C. 119 based on the following
prior foreign application filed in the following foreign country on the date indicated:

<u>Country</u>	<u>Application No.</u>	<u>Date</u>
Japan	2003-110976	April 16, 2003

In support of this claim, a certified copy of the said original foreign application
will be filed shortly.

Dated: April 15, 2004

Respectfully submitted,

By 

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